

Notice of References Cited

Application/Control No.

10/594,922

Applicant(s)/Patent Under
Reexamination
ANDO ET AL.

Examiner

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Art Unit

1796

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,786,658 A	11-1988	Hashimoto et al.	522/121
*	B	US-2007/0218289 A1	09-2007	Ando et al.	428/411.1
	C	US-			
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	I	US-			
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	L	US-			
	M	US-			

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*	N	JP 2000063682 A	02-2000	Japan	HASEGAWA et al.	
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	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of JP 2000-063682 A (2/29/2000), Hasegawa et al.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.